Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/017,261	DAMON ET AL.	
Examiner	Art Unit	
CHUONG T HO	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
370 370	3895	07/26/06	Ol-1	
370 370	409			
370	395.31	t l		
370	395.3			
709	203			
709	2381			
709	245	*		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
370	392	07/26/01	CH		
370	389				
376	395.31				
709	238				
709	245				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST (Text rearch, Class rearch) EAST	07/26/06	94	
class rearch)			
STN			
IEEE	 		